

STGW30M65DF2, STGWA30M65DF2

Trench gate field-stop IGBTs, M series 650 V, 30 A low-loss in TO-247 and TO-247 long leads packages

Datasheet - production data

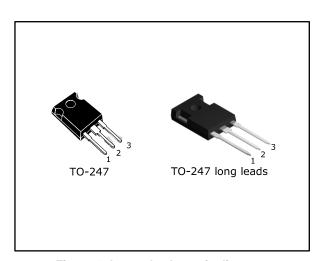
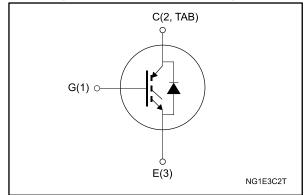


Figure 1: Internal schematic diagram



Features

- 6 μs of minimum short-circuit withstand time
- $V_{CE(sat)} = 1.55 \text{ V (typ.)} @ I_C = 30 \text{ A}$
- Tight parameters distribution
- Safer paralleling
- Low thermal resistance
- Soft and very fast recovery antiparallel diode

Applications

- Motor control
- UPS
- PFC

Description

These devices are IGBTs developed using an advanced proprietary trench gate field-stop structure. The devices are part of the M series IGBTs, which represent an optimal balance between inverter system performance and efficiency where low-loss and short-circuit functionality are essential. Furthermore, the positive $V_{\text{CE(sat)}}$ temperature coefficient and tight parameter distribution result in safer paralleling operation.

Table 1: Device summary

Order code	Marking	Package	Packaging
STGW30M65DF2	G30M65DF2	TO-247	Tube
STGWA30M65DF2	G30M65DF2	TO-247 long leads	Tube

April 2017 DocID027768 Rev 5 1/17

Contents

1	Electric	al ratings	3
2	Electric	cal characteristics	4
	2.1	Electrical characteristics (curves)	6
3	Test cir	cuits	11
4	Packag	e information	12
	4.1	TO-247 package information	12
	4.2	TO-247 long leads package information	14
5	Revisio	n history	16



1 Electrical ratings

Table 2: Absolute maximum ratings

Symbol	Parameter	Value	Unit
Vces	Collector-emitter voltage (V _{GE} = 0 V)	650	V
lc	Continuous collector current at T _C = 25 °C	60	Α
Ic	Continuous collector current at T _C = 100 °C	30	Α
I _{CP} ⁽¹⁾	Pulsed collector current	120	Α
V_{GE}	Gate-emitter voltage	±20	V
l _F	Continuous forward current at T _C = 25 °C	60	Α
l _F	Continuous forward current at T _C = 100 °C	30	Α
I _{FP} ⁽¹⁾	Pulsed forward current	120	Α
Ртот	Total dissipation at T _C = 25 °C	258	W
T _{STG}	Storage temperature range	-55 to 150	°C
TJ	Operating junction temperature range	-55 to 175	ů

Notes:

Table 3: Thermal data

Symbol	Parameter	Value	Unit
RthJC	Thermal resistance junction-case IGBT	0.58	°C/W
RthJC	Thermal resistance junction-case diode	1.47	°C/W
RthJA	Thermal resistance junction-ambient	50	°C/W

 $^{^{(1)}}$ Pulse width limited by maximum junction temperature.

2 Electrical characteristics

T_C = 25 °C unless otherwise specified

Table 4: Static characteristics

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)CES}	Collector-emitter breakdown voltage	$V_{GE} = 0 \text{ V}, I_{C} = 250 \mu\text{A}$	650			٧
		$V_{GE} = 15 \text{ V}, I_{C} = 30 \text{ A}$		1.55	2.0	
V _{CE(sat)} Collector-emitter saturation voltage	V _{GE} = 15 V, I _C = 30 A, T _J = 125 °C		1.95		V	
	voltage	V _{GE} = 15 V, I _C = 30 A, T _J = 175 °C		2.1		
		I _F = 30 A		1.85	2.65	
V_{F}	Forward on-voltage	I _F = 30 A, T _J = 125 °C		1.6		V
		I _F = 30 A, T _J = 175 °C		1.5		
$V_{GE(th)}$	Gate threshold voltage	$V_{CE} = V_{GE}$, $I_C = 500 \mu A$	5	6	7	V
I _{CES}	Collector cut-off current	V _{GE} = 0 V, V _{CE} = 650 V			25	μΑ
I _{GES}	Gate-emitter leakage current	V _{CE} = 0 V, V _{GE} = ±20 V			±250	μΑ

Table 5: Dynamic characteristics

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
Cies	Input capacitance		-	2490	1	
Coes	Output capacitance	V _{CE} = 25 V, f = 1 MHz, V _{GE} = 0 V	-	143	ı	pF
Cres	Reverse transfer capacitance	VGL — V	-	46	ı	
Qg	Total gate charge $V_{CC} = 520 \text{ V}, I_C = 30 \text{ A},$		-	80	ı	
Q_{ge}	Gate-emitter charge	V _{GE} = 0 to 15 V (see <i>Figure 30: "Gate</i>	-	18	1	nC
Q _{gc}	Gate-collector charge	charge test circuit")	-	32	-	

Table 6: IGBT switching characteristics (inductive load)

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t _{d(on)}	Turn-on delay time			31.6	-	ns
tr	Current rise time			13.4	-	ns
(di/dt) _{on}	Turn-on current slope	V _{CE} = 400 V, I _C = 30 A,		1791	-	A/µs
t _{d(off)}	Turn-off-delay time	$V_{GE} = 400 \text{ V}, 10 = 30 \text{ A},$ $V_{GE} = 15 \text{ V}, R_{G} = 10 \Omega$		115	-	ns
t _f	Current fall time	(see Figure 29: " Test circuit		110	1	ns
E _{on} ⁽¹⁾	Turn-on switching energy	for inductive load switching")		0.3	-	mJ
E _{off} (2)	Turn-off switching energy			0.96	-	mJ
Ets	Total switching energy			1.26	-	mJ
t _{d(on)}	Turn-on delay time			30	-	ns
tr	Current rise time			17	-	ns
(di/dt) _{on}	Turn-on current slope	V _{CE} = 400 V, I _C = 30 A,		1435	-	A/µs
t _{d(off)}	Turn-off-delay time	$V_{GE} = 15 \text{ V}, R_{G} = 10 \Omega,$		116	-	ns
tf	Current fall time	T _J = 175 °C (see <i>Figure 29: "Test circuit</i>		194	-	ns
E _{on} ⁽¹⁾	Turn-on switching energy	for inductive load switching")		0.67	-	mJ
E _{off} (2)	Turn-off switching energy			1.36	-	mJ
Ets	Total switching energy			2.03	-	mJ
	Short-circuit withstand time	V _{CC} ≤ 400 V, V _{GE} = 13 V, T _{Jstart} = 150 °C	10		-	-10
t _{sc}	Short-circuit withstand time	V _{CC} ≤ 400 V, V _{GE} = 15 V, T _{Jstart} = 150 °C	6		-	μs

Notes:

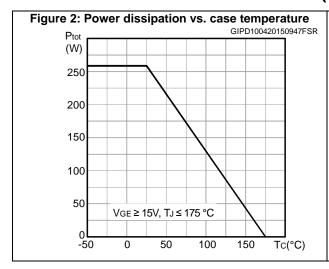
Table 7: Diode switching characteristics (inductive load)

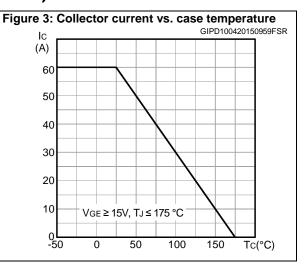
Symbol	Parameter Test conditions		Min.	Тур.	Max.	Unit
t _{rr}	Reverse recovery time		ı	140	ı	ns
Q_{rr}	Reverse recovery charge	I _F = 30 A, V _R = 400 V,	ı	880	ı	nC
Irrm	Reverse recovery current	V _{GE} = 15 V, di/dt = 1000 A/µs	ı	17	1	Α
dl _{rr} /dt	Peak rate of fall of reverse recovery current during t _b	(see Figure 29: "Test circuit for inductive load switching")	ı	650	ı	A/µs
Err	Reverse recovery energy		1	115	1	μJ
t _{rr}	Reverse recovery time		ı	244	ı	ns
Qrr	Reverse recovery charge I _F = 30 A, V _R = 400 V,		ı	2743	ı	nC
I _{rrm}	Reverse recovery current	V _{GE} = 15 V, di/dt = 1000 A/μs, T _J = 175 °C	1	25	1	Α
dl _{rr} /dt	Peak rate of fall of reverse recovery current during t _b	(see Figure 29: "Test circuit for inductive load switching")	ı	220	1	A/µs
Err	Reverse recovery energy		-	320	-	μJ

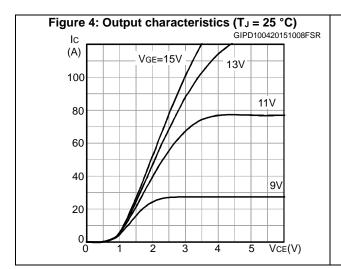
⁽¹⁾Including the reverse recovery of the diode.

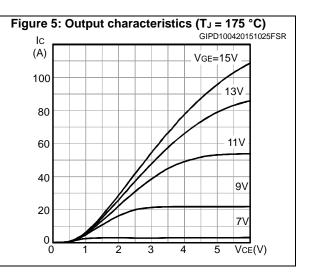
 $[\]ensuremath{^{(2)}}\mbox{Including}$ the tail of the collector current.

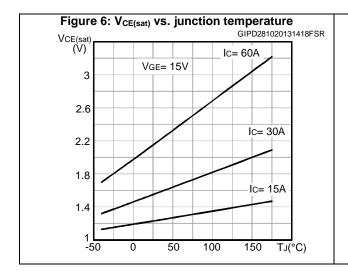
2.1 Electrical characteristics (curves)

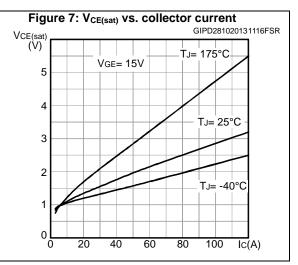




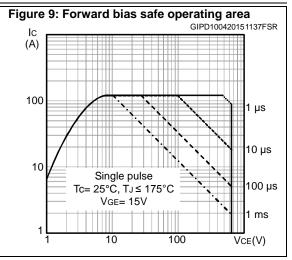


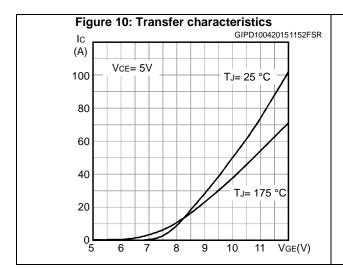


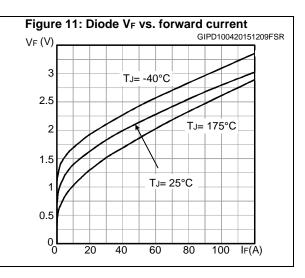


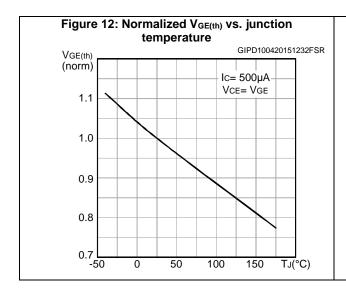


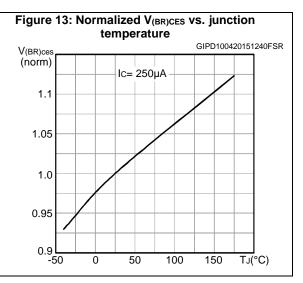
6/17 DocID027768 Rev 5

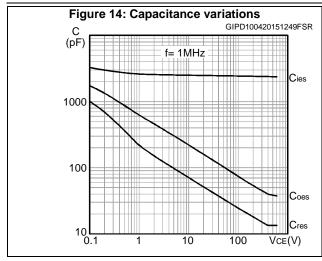


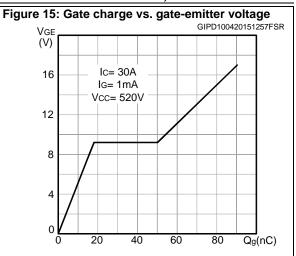


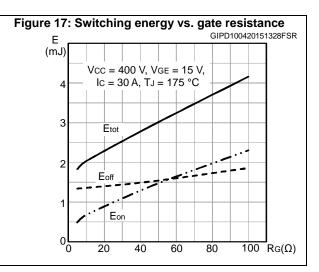


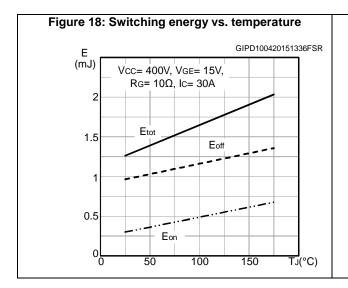


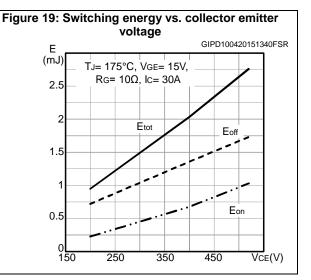












57

Figure 20: Short-circuit time and current vs. V_{GE} GIPD100420151351FSR Isc(A) Vcc ≤ 400V, TJ ≤ 150°C (µs) 150 20 tsc 120 15 90 10 60 0 _] 30 VGE(V) 10 14 15 12 13

Figure 21: Switching times vs. collector current GIPD100420151403FSR (ns) TJ= 175°C, VGE= 15V, Rg= 10Ω , Vcc= 400Vtf 100 td(off) td(on) 10 tr 30 10 20 40 50 Ic(A)

Figure 22: Switching times vs. gate resistance

(ns)

TJ= 175°C, VGE= 15V,
IC= 30A, VCC= 400V

td(off)

td(off)

100

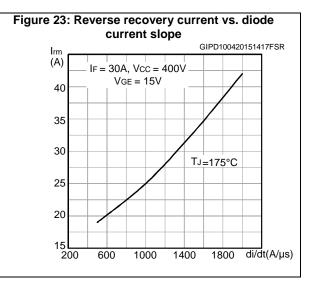
20

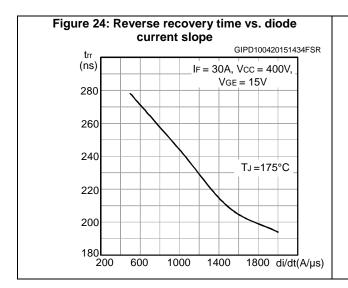
40

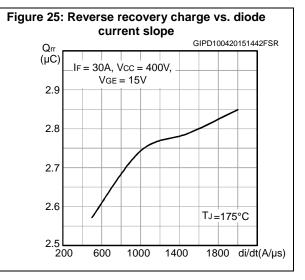
60

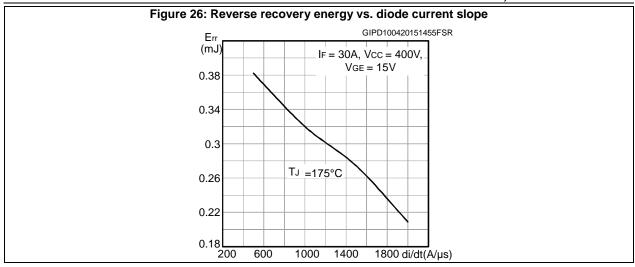
80

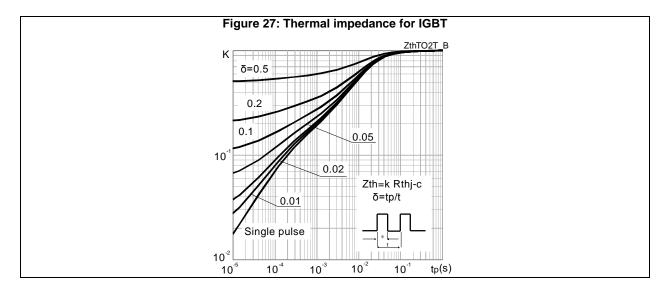
RG(Ω)

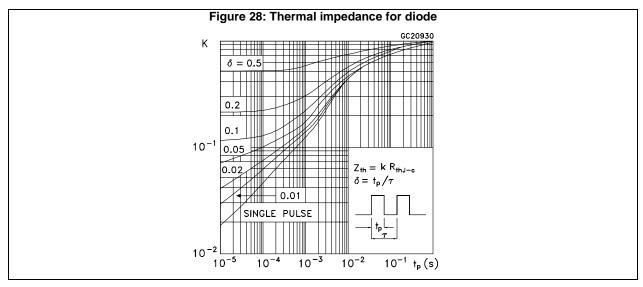








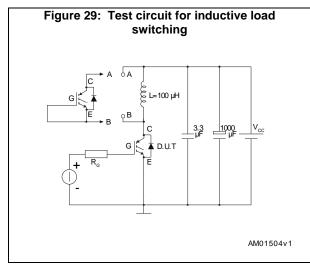


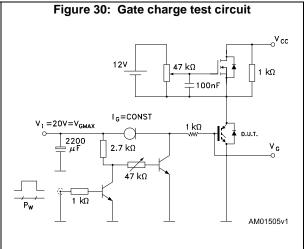


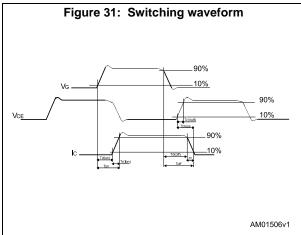
DocID027768 Rev 5

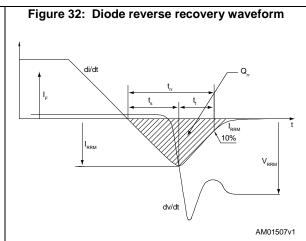
10/17

3 Test circuits









4 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: **www.st.com**. ECOPACK® is an ST trademark.

4.1 TO-247 package information

HEAT-SINK PLANE S øR Ľ2 *b1 b2* BACK VIEW 0075325_8

Figure 33: TO-247 package outline

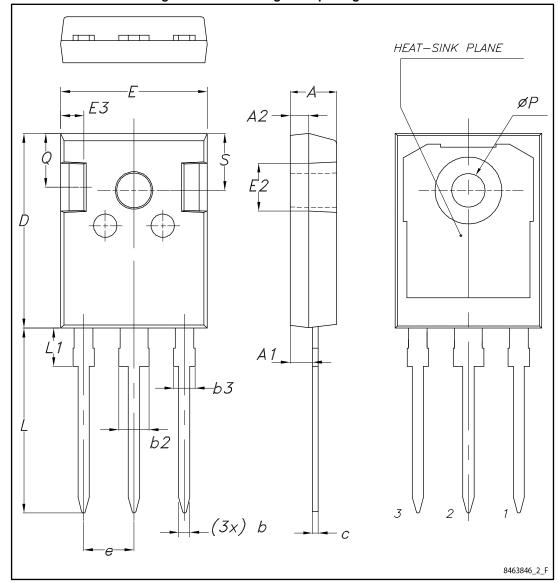
577

Table 8: TO-247 package mechanical data

rusie 6. 10 247 publiage modification data			
Dim.		mm	
Dilli.	Min.	Тур.	Max.
А	4.85		5.15
A1	2.20		2.60
b	1.0		1.40
b1	2.0		2.40
b2	3.0		3.40
С	0.40		0.80
D	19.85		20.15
Е	15.45		15.75
е	5.30	5.45	5.60
L	14.20		14.80
L1	3.70		4.30
L2		18.50	
ØP	3.55		3.65
ØR	4.50		5.50
S	5.30	5.50	5.70

4.2 TO-247 long leads package information

Figure 34: TO-247 long leads package outline



577

Table 9: TO-247 long leads package mechanical data

	mm		
Dim.	Min.	Тур.	Max.
А	4.90	5.00	5.10
A1	2.31	2.41	2.51
A2	1.90	2.00	2.10
b	1.16		1.26
b2			3.25
b3			2.25
С	0.59		0.66
D	20.90	21.00	21.10
E	15.70	15.80	15.90
E2	4.90	5.00	5.10
E3	2.40	2.50	2.60
е	5.34	5.44	5.54
L	19.80	19.92	20.10
L1			4.30
Р	3.50	3.60	3.70
Q	5.60		6.00
S	6.05	6.15	6.25

5 Revision history

Table 10: Document revision history

Date	Date Revision Changes	
04-May-2015	1	First release.
14-Sep-2015	2	Updated features in cover page and added new t _{SC} condition in in Table 6: "IGBT switching characteristics (inductive load)".
18-Dec-2015	3	Added part number STGW30M65DF2 Added Section 4.1: "TO-247 package information" Minor text changes.
20-May-2016	4	Updated features in cover page. Minor text changes
11-Apr-2017	5	Updated document title. Updated Table 4: "Static characteristics", Table 6: "IGBT switching characteristics (inductive load)" and Table 7: "Diode switching characteristics (inductive load)". Updated Section 4: "Package information". Minor text changes

16/17 DocID027768 Rev 5

IMPORTANT NOTICE - PLEASE READ CAREFULLY

STMicroelectronics NV and its subsidiaries ("ST") reserve the right to make changes, corrections, enhancements, modifications, and improvements to ST products and/or to this document at any time without notice. Purchasers should obtain the latest relevant information on ST products before placing orders. ST products are sold pursuant to ST's terms and conditions of sale in place at the time of order acknowledgement.

Purchasers are solely responsible for the choice, selection, and use of ST products and ST assumes no liability for application assistance or the design of Purchasers' products.

No license, express or implied, to any intellectual property right is granted by ST herein.

Resale of ST products with provisions different from the information set forth herein shall void any warranty granted by ST for such product.

ST and the ST logo are trademarks of ST. All other product or service names are the property of their respective owners.

Information in this document supersedes and replaces information previously supplied in any prior versions of this document.

© 2017 STMicroelectronics - All rights reserved

